









Seminar: Principles of Optical Metrology (2 SWS)

Courses: Electrical Eng. Master,

ECE Master in combination with Optical Metrology Lab.

Requirements: Basics in Optics and Measurement Technology

Each attendee choses one of the topics below and prepares a 40 minutes lecture.

Topics:

- 1. Wave Optics, Wave Phenomena and Propagation
- 2. Diffraction, Diffractive Optical Elements and Applications
- 3. Fourier Optics and Optical Systems
- 4. Imaging and Vision Systems based on Digital Image Processing
- 5. Confocal Microscopy and Applications in Material Science
- 6. Atomic Force and Scanning Near-Field Optical Microscopy
- 7. Length Measuring Interferometry
- 8. Fiber Optic Sensors and Applications
- 9. Microoptics and Adaptive Optics in Measurement Systems
- 10. Speckles and Light Scattering in Optical Measurement
- 11. Digital Holography, Digital Holographic Microscopy
- 12. Microscopic Imaging and Optical Resolution*
- 13. Interference Microscopy*
- 14. The Optical Transfer Function*

ECE Master students combine the seminar with an Optical Metrology Lab.

^{*}Presentation given by measurement technology group members